

RD51 MPGD School Lab 1: Detector Assembly

Group 4

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Daily Laboratory Exercises

Lab 1: Detector Assembly

Lab 2: Detector Operation Lab 3: Detector Characterization Lab 4: Readout Techniques Lab 5: Simulation

<u>Aims</u>

- Familiarisation with cleanroom code of conduct.
- Assembly of triple-GEM structure.
- Quality control measures.
- Functionality testing of structures.



Triple - GEM Detector



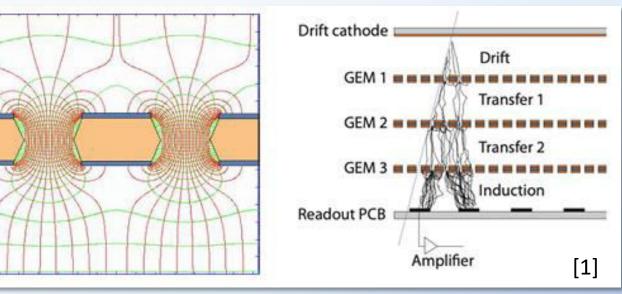
Standard GEM foils.

50 μm thick insulating polyimide dielectric.

Clad on both sides with 5 µm copper. A matrix of holes with high density are etched into the dielectric using photolithography.

Biconical with 50 μm inner diameter /70 μm outer diameter/pitch 140 $\mu m.$

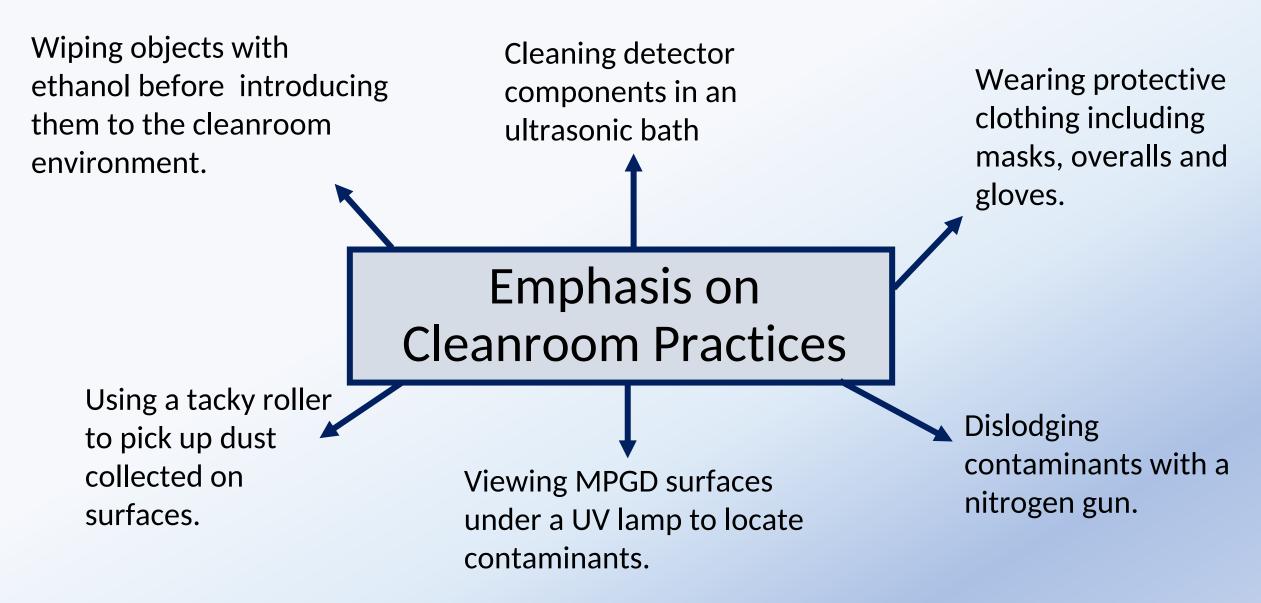
A high voltage is applied across copper electrodes to produce regions of high electric field strength where field lines are focused in the holes.



Electrons from primary ionization produced in the drift region undergo multiplication from avalanche processes in the holes, which produces a signal readout from the anode.

Triple GEM structures are used to provide higher overall gain with a reduced probability of discharges, as the multiplication is divided across stages.

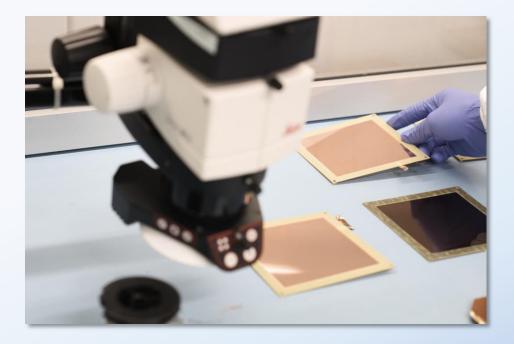
[1] F. Sauli, GEM: A new concept for electron amplification in gas detectors. NIM A 386 (1997) 531



These procedures can prevent damage caused by contaminants inside the detector, which necessitate time-consuming repairs! 4

Quality Checks – Optical Inspection

A microscope was used to measure hole sizes and pitches and search for defects such as over-etching, under-etching, scratches and damage from sparks.



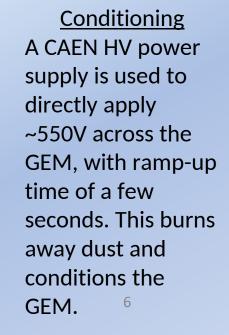


Quality Checks – Leakage Current

Principle

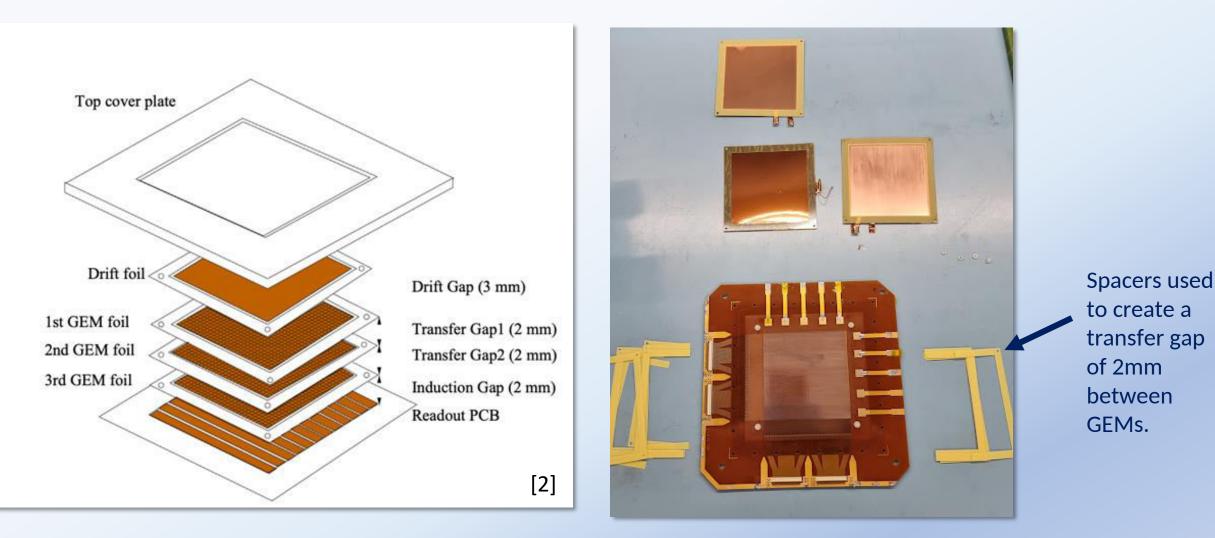
- The leakage current observed when applying high voltage is determined by the surface conductivity of the dielectric.
- The conductivity depends on the quality of the foil and also it's cleanliness.
- Foil defects and dust particles form an electrical bridge, increasing the current flow through the foil.
- Measuring the current thus provides information on the foil quality and cleanliness.

Temperature and humidity can be monitored with a sensor in a flow box.



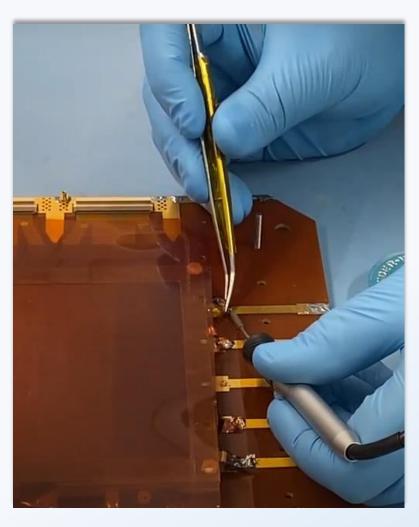
The structures can be tested in a flow box flushed with dry nitrogen, to control humidity.

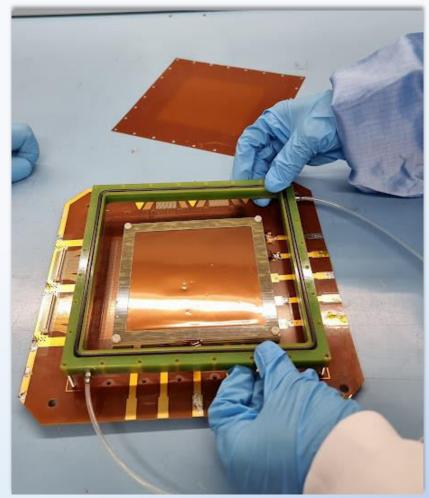
Assembly of Triple-GEM Structure

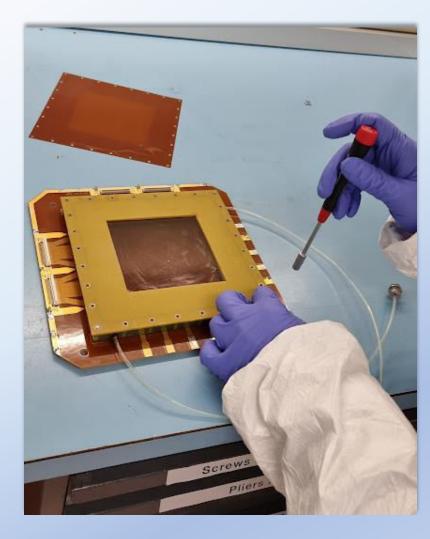


[2] S. Chatterjee et al., Study of uniformity of characteristics over the surface for triple GEM detector, NIM A 862 (2017) 25

Assembly of Triple-GEM Structure







The GEM surfaces were protected with a Kapton sheet whilst soldering the electrical connections.

A gas-tight structure was created with an O-ring embedded in a frame.

A top cover plate with a Kapton window was used to close the volume.

Summary of Lab 1

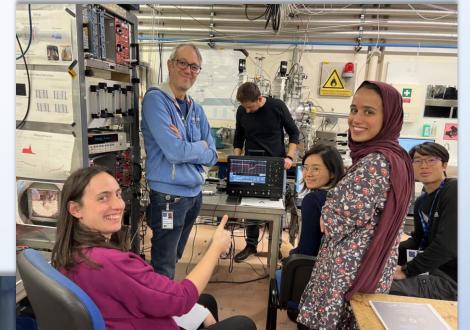
Good practices for cleanroom procedures were discussed.

 Quality control was carried out via optical inspection and measurements of leakage current.

Accepted GEM foils were mounted in a triple-GEM layout.

<u>A final note:</u>

THANK YOU MPGD School organisers ...and lecturers and tutors!





Group 4 enjoying another lab exercise, operating resistive Micromegas.